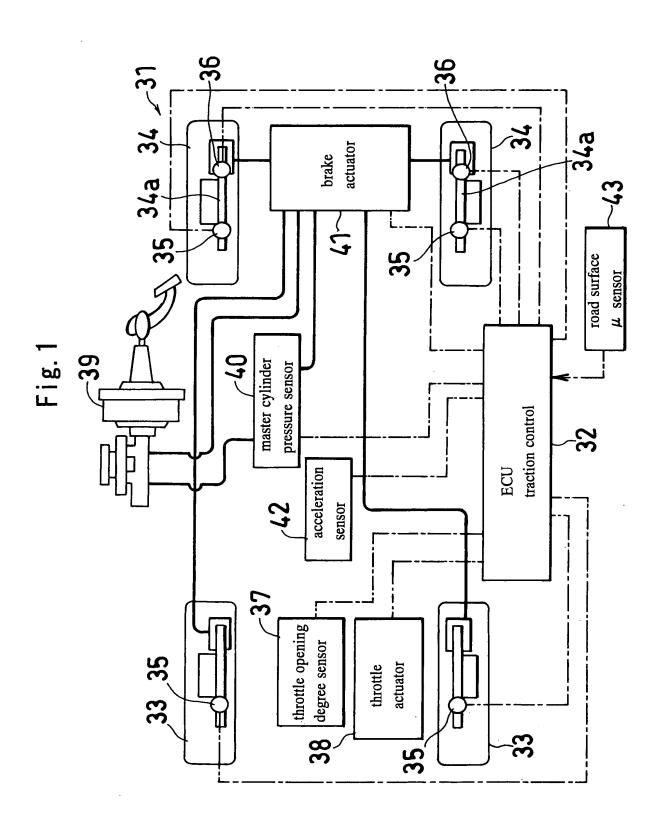
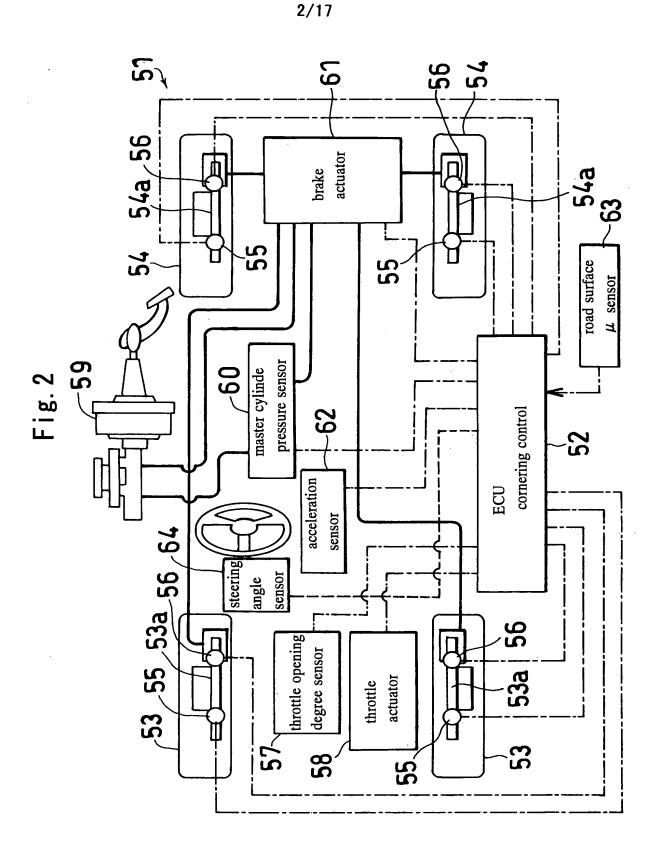
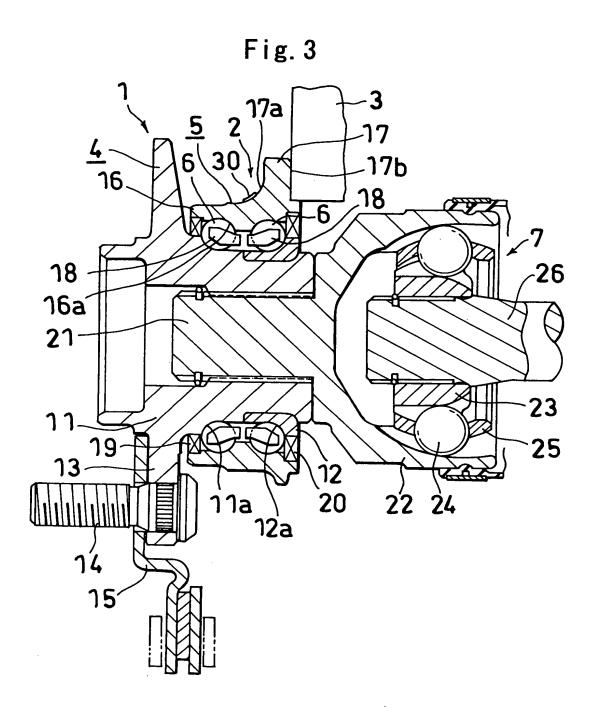
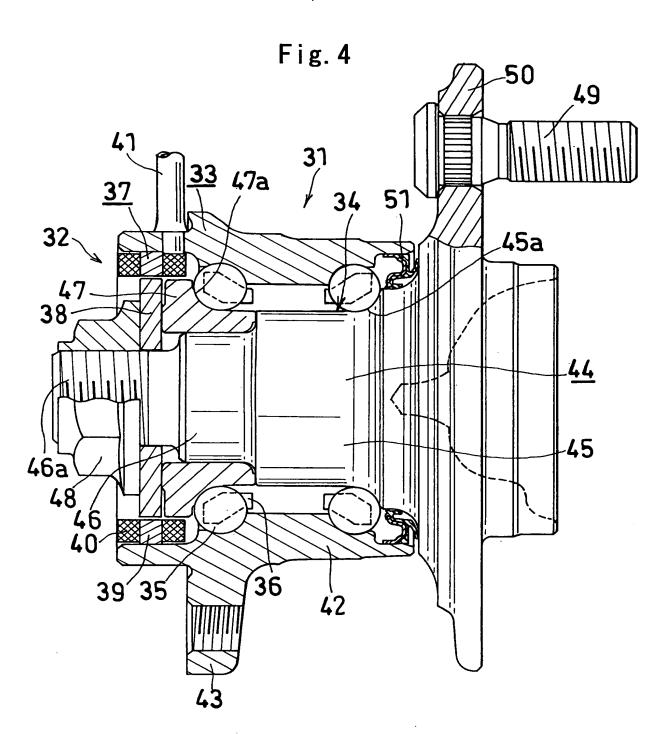
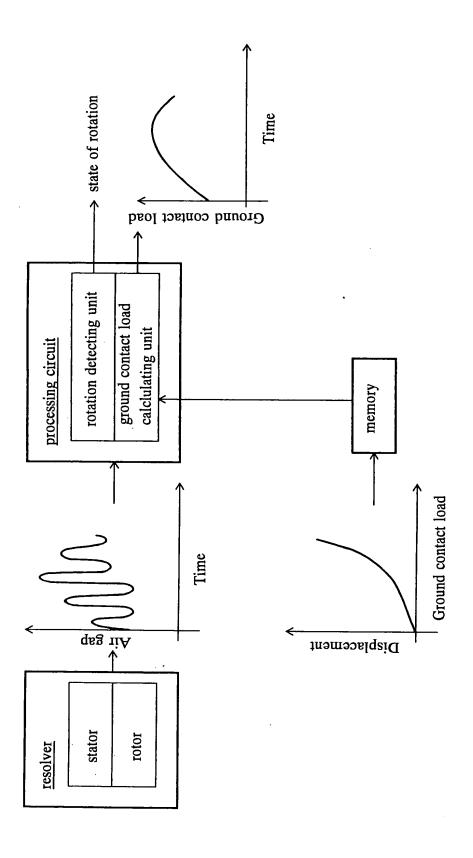
OF_/7 10/519944 Rec'd PCT/PTO 29 DEC 2004

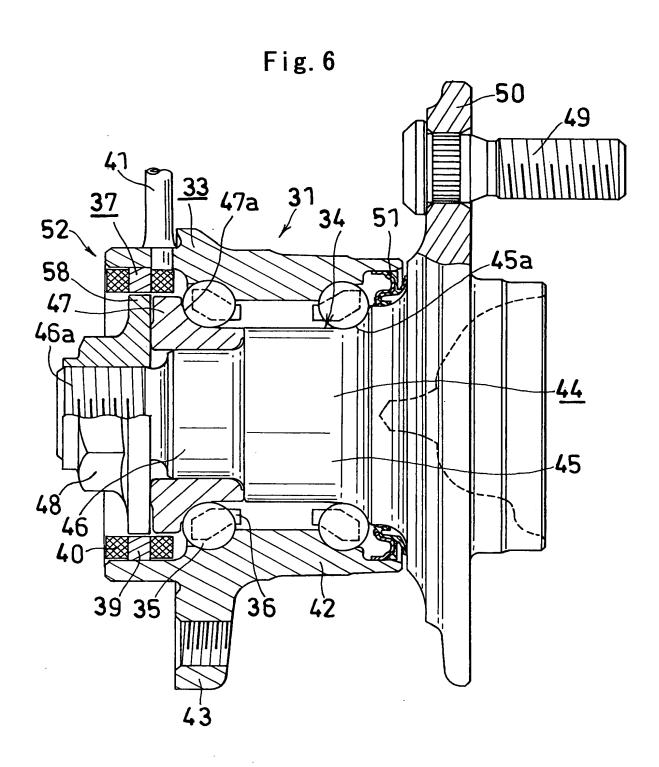




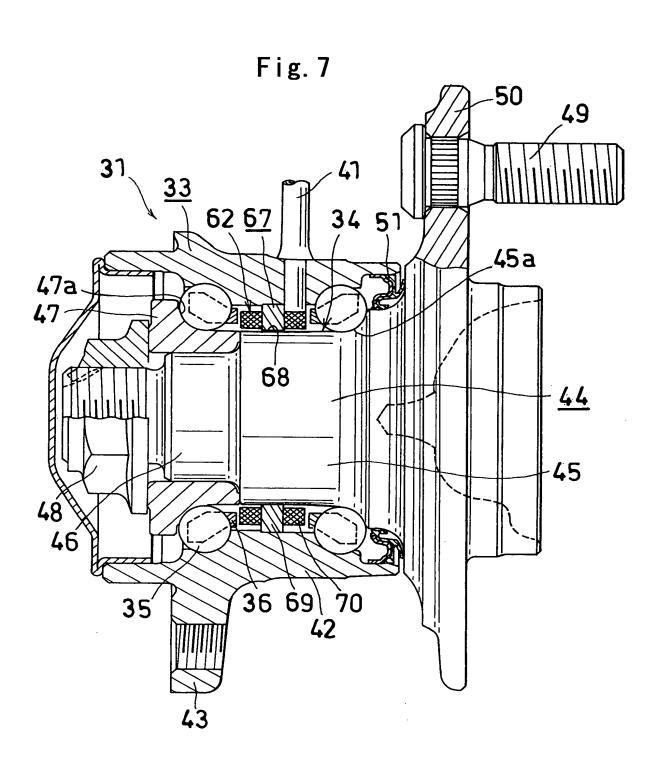


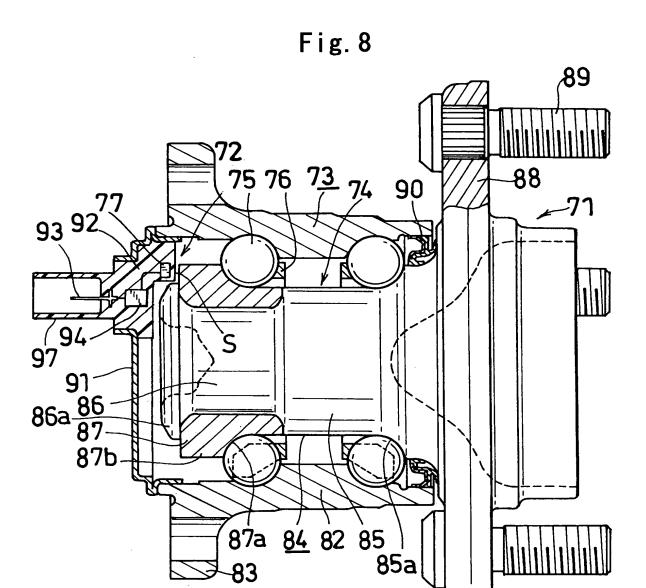






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OBLON ET AL (703) 413-3000 1 0 5 1 9 9 4 4 DOCKET # 263855865 SHEET 9 OF 17 REC'S PCT/PTO 2 9 DEC 2004

Fig. 9

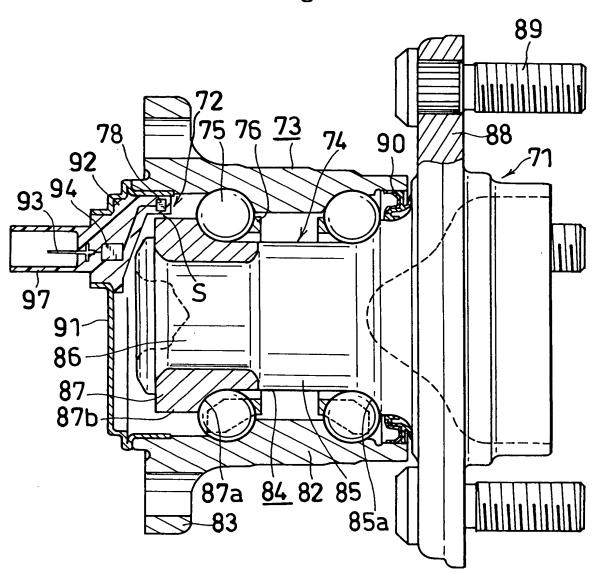


Fig. 10

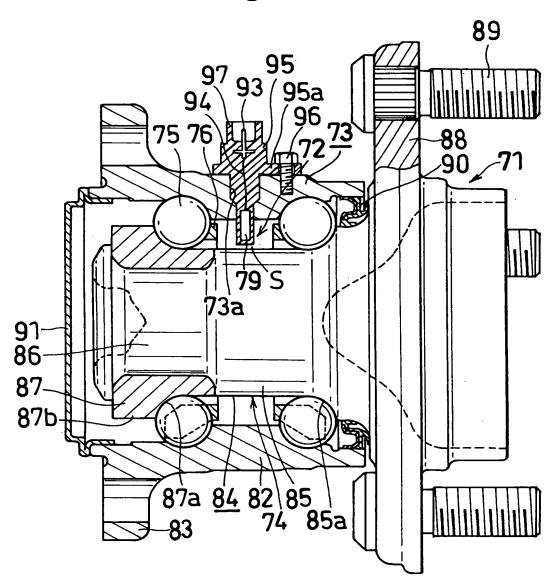


Fig. 11

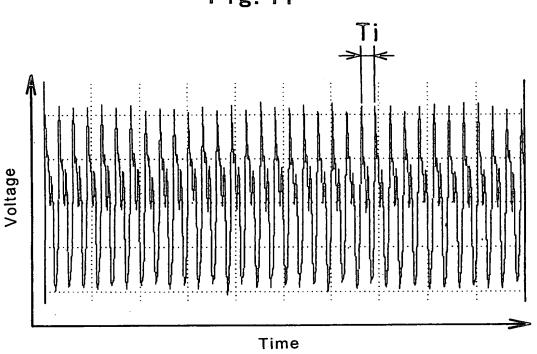
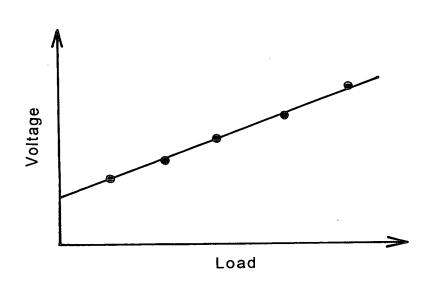
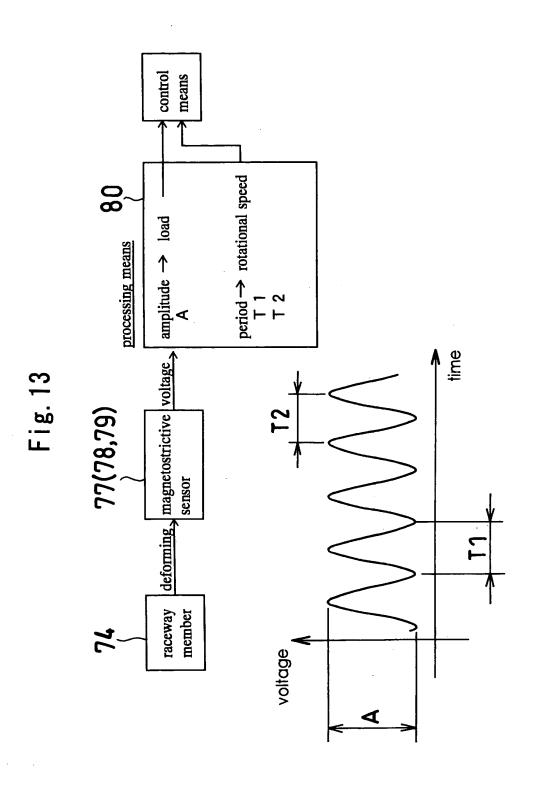
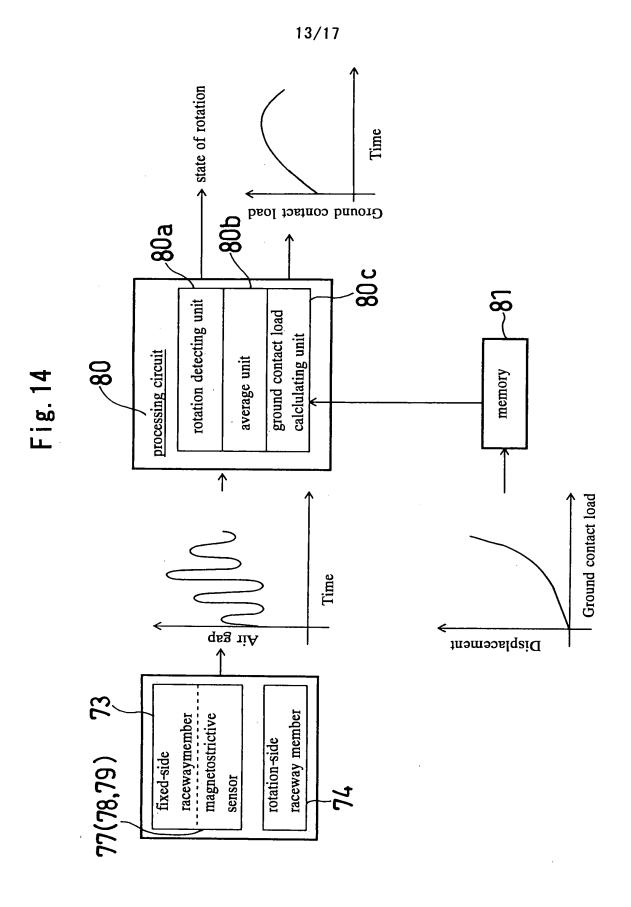


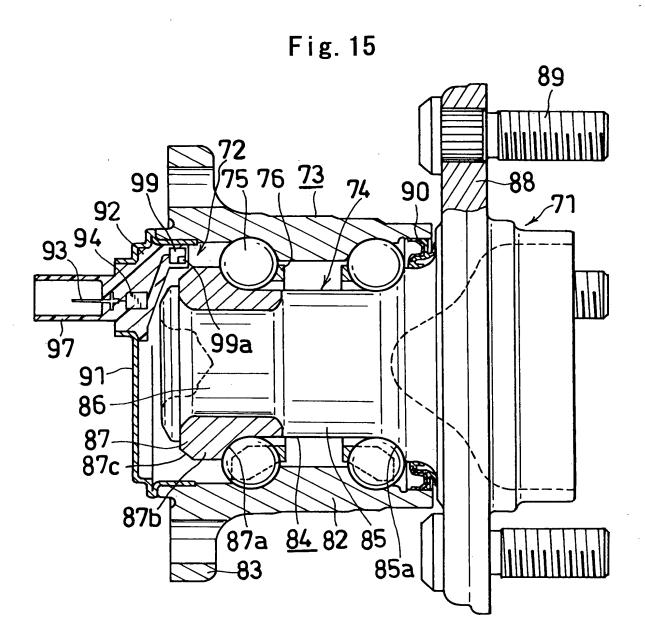
Fig. 12



12/17







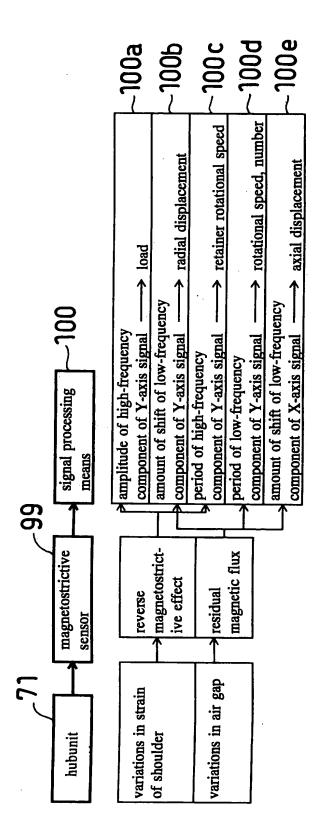
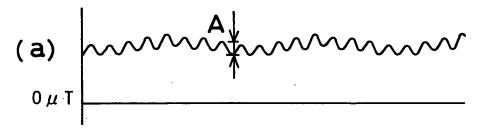


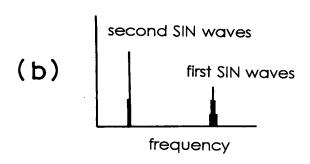
Fig. 16

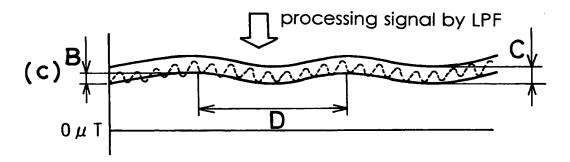
Fig. 17

waveform of Y-direction detecting element



subjecting signal to FFT



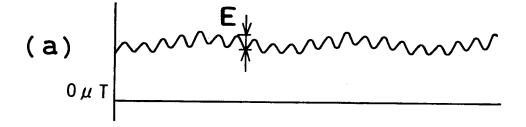


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17/17

Fig. 18

waveform of X-direction detecting element



processing signal by LPF

(b) $0 \mu T$